intel.

Product Change Notification

| Change Notification #: | 118299 - 00 |
|------------------------|--|
| Change Title: | Select Intel® MAX® 10 Series Products, |
| | PCN 118299-00, Manufacturing Site, Product |
| | Marking, Product Material, |
| | WLCSP RDL/Bump Site Transfer and |
| | Package Appearance Change |
| Date of Publication: | June 3, 2021 |

Key Characteristics of the Change:

Manufacturing Site, Product Marking, Product Material

Forecasted Key Milestones:

| Milestone | Date |
|--|------------------|
| Last date to acknowledge receipt of this notification ¹ | July 12, 2021 |
| Earliest change implementation | November 1, 2021 |

Note 1: J-STD-046, section 3.2.3.1b, stipulates that lack of acknowledgement of the PCN within 30 days constitutes acceptance of the change.

Description of Change to the Customer:

This is the same change described in PCN2124 issued on May 28, 2021.

Intel is announcing a change to the RDL/Bump site and package appearance on selected Intel MAX® 10 products in Wafer Level Chip Scale Package (WLCSP). The change will not impact fit, function, quality and reliability, and the post-change products will meet existing electrical and mechanical specifications.

Table 1: Change Details

| | Change From | Change To |
|----------------------------------|---|---|
| RDL and Bump Site/Location | Site: Taiwan Semiconductor Manufacturing Company (TSMC) Location: No. 6, Li-Hsin Rd. 6th HsinChu Science Park HsinChu, Taiwan | Site: Advanced Semiconductor Engineering, Inc (ASEK) Location: 26, Chin 3rd Rd., Nanzih Dist, Kaohsiung, 811, Taiwan |

| Package Construction& Appearance | WLCSP- UFI (UBM-free Interconnect) solution Black mold compound with exposed top side of solder balls | Standard WLCSP Design pattern on the active area and entire solder balls are visible. |
|--|--|---|
| Package Outline Drawing (POD) | Only A1 & A2 dimensions have changed, overall A (height) is the same. So table 3 below. | |

Table 2: Package Appearance



Table 3: Package Outline Drawing (POD)

| | Existing POD (Change From) | POD after Change (Change To) | Comments/ Notes | |
|----------|-------------------------------|---------------------------------|--------------------|--|
| A(Nom) | 0.46 mm | 0.46mm | No change | |
| A1 (Nom) | 0.13 mm | 0.20 mm | | |
| A2 (Nom) | 0.33 mm | 0.26 mm | | |
| D | 10M08 = 4.496 mm BSC | 10M08 = 4.496 mm BSC | No Change | |
| | 10M02 = 3.396 mm BSC | 10M02 = 3.396 mm BSC | | |
| Е | 10M08 = 4.377 mm BSC | 10M08 = 4.377 mm BSC | No Change | |
| | 10M02 = 3.466 mm BSC | 10M02 = 3.466 mm BSC | | |
| | | | | |

Reason for Change:

Supply continuity since existing site has discontinued UFI (UBM-free Interconnect) packaging.

Qualification Data:

Qualification testing was performed to further evaluate the quality and reliability performance of ASEK for the products specific to this PCN.

| Test | Time point | Conditions | Sample Size | Lots# H3417 | Lots# H3418 | Lots# H3419 |
|--|----------------|----------------------------|-------------|----------------|----------------|----------------|
| Unbiased Highly Accelerated Stress Test (uHAST) | 192hrs | 130°C / 85%RH | 135 | 0/45 | 0/45 | 0/45 |
| Highly Accelerated Stress Test (HAST) | 192hrs | 130°C / 85%RH with bias | 135 | 0/45 | 0/45 | 0/45 |
| Temperature Cycle Test (TCB) | 1200 Cycles | -55°C /125°C | 135 | 0/45 | 0/45 | 0/45 |
| High Temp Storage (Bake) | 1500hrs | 150°C | 135 | 0/45 | 0/45 | 0/45 |

Table 6A: Component Level Reliability Test Data All tests passed with zero failures

Note 1: Preconditioning performed according to J-STD-020, MSL 1 @ 260C reflow

Note 2: Qualification testing and sample size based on standard J-STD-020 requirements

| Table 6B: Board Level Rel | liability Test Data |
|---------------------------|---------------------|
|---------------------------|---------------------|

| Test | Condition | ondition Sample Size (Units) | |
|---|---------------------------------------|------------------------------|------|
| Temp Cycle (reference to IPC-9701) | TCT -40/125°C (1100cycles) | 35 | Pass |
| Drop test (reference to JESD22-B111) | Condition B (1500G,0.5ms) 30 drops | 30 | Pass |
| Bend test (reference to JESD22-B113) | 200K cycles | 30 | Pass |

Customer Impact of Change and Recommended Action:

There is no impact to fit, function, quality, and reliability of the product. The products will meet existing electrical and mechanical specifications.

Customers are requested to:

- 1. Acknowledge receipt of this notification.
- 2. Review and inform us, at the earliest convenience, of any questions or concerns regarding this change.

Upon implementation, Intel will ship either pre-change or post-change materials.

Products Affected / Intel Ordering Codes:

| Stepping | Product Code | S-Spec | MM# |
|----------|--|--|--|
| A1 | 10M02DC0608 | S R4KQ | 965479 |
| A1 | 10M08DC0716 | S R4NT | 965587 |
| A1 | 10M08DC2882 | S R6H6 | 967757 |
| A1 | 10M08DF2883 | S R6H7 | 967758 |
| A1 | 10M08DF3199 | S R6SR | 968099 |
| A1 | 10M02DC3922 | S R7DB | 968811 |
| A1 | 10M02DC8864 | S RBJV | 973658 |
| A1 | 10M08DC8872 | S RBK2 | 973666 |
| A1 | 10M08DF8873 | S RBK3 | 973667 |
| | A1 A1 A1 A1 A1 A1 A1 | A110M02DC0608A110M08DC0716A110M08DC2882A110M08DF2883A110M08DF3199A110M02DC3922A110M02DC8864A110M08DC8872 | A110M02DC0608S R4KQA110M08DC0716S R4NTA110M08DC2882S R6H6A110M08DF2883S R6H7A110M08DF3199S R6SRA110M02DC3922S R7DBA110M02DC8864S RBJVA110M08DC8872S RBK2 |

PCN Revision History:

| Date of Revision: |
|-------------------|
| June 3, 2021 |

Revision Number: 00

Reason: Originally Published PCN

intel.

Product Change Notification 118299 - 00

INFORMATION IN THIS DOCUMENT IS PROVIDED IN CONNECTION WITH INTEL PRODUCTS. NO LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT. EXCEPT AS PROVIDED IN INTEL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, INTEL ASSUMES NO LIABILITY WHATSOEVER AND INTEL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY, RELATING TO SALE AND/OR USE OF INTEL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

A "Mission Critical Application" is any application in which failure of the Intel Product could result, directly or indirectly, in personal injury or death. SHOULD YOU PURCHASE OR USE INTEL'S PRODUCTS FOR ANY SUCH MISSION CRITICAL APPLICATION, YOU SHALL INDEMNIFY AND HOLD INTEL AND ITS SUBSIDIARIES, SUBCONTRACTORS AND AFFILIATES, AND THE DIRECTORS, OFFICERS, AND EMPLOYEES OF EACH, HARMLESS AGAINST ALL CLAIMS COSTS, DAMAGES, AND EXPENSES AND REASONABLE ATTORNEYS' FEES ARISING OUT OF, DIRECTLY OR INDIRECTLY, ANY CLAIM OF PRODUCT LIABILITY, PERSONAL INJURY, OR DEATH ARISING IN ANY WAY OUT OF SUCH MISSION CRITICAL APPLICATION, WHETHER OR NOT INTEL OR ITS SUBCONTRACTOR WAS NEGLIGENT IN THE DESIGN, MANUFACTURE, OR WARNING OF THE INTEL PRODUCT OR ANY OF ITS PARTS.

Intel may make changes to specifications and product descriptions at any time, without notice. Designers must not rely on the absence or characteristics of any features or instructions marked "reserved" or "undefined". Intel reserves these for future definition and shall have no responsibility whatsoever for conflicts or incompatibilities arising from future changes to them. The information here is subject to change without notice. Do not finalize a design with this information.

The products described in this document may contain design defects or errors known as errata which may cause the product to deviate from published specifications. Current characterized errata are available on request.

Should you have any issues with the timeline or content of this change, please contact the Intel Representative(s) for your geographic location listed below. No response from customers will be deemed as acceptance of the change and the change will be implemented pursuant to the key milestones set forth in this attached PCN.

Americas Contact: asmo.pcn@intel.com Asia Pacific/PRC Contact: apacgccb@intel.com Europe Email: eccb@intel.com Japan Email: jccb.ijkk@intel.com

Copyright © Intel Corporation 2021. Other names and brands may be claimed as the property of others.

3D XPoint, ACEX, Altera, APEX, AnyWAN, Arria, Avalon, Axxia, BlueMoon, BunnyPeople, Celeron, Centrino, Cilk, CONVERGATE, Cyclone, Docea, eASIC, easicopy, Enpirion, Flexpipe, Hyperflex, Intel, the Intel logo, Intel Adaptix, Intel Agilex, Intel Atom, Intel CoFluent, Intel Core, Intel. Experience What's Inside, the Intel. Experience What's Inside logo, Intel Falcon, Intel Inside, the Intel Inside logo, Intel Nervana, Intel Optane, Intel RealSense, Intel Shooting Star, Intel Sirius, Intel SpeedStep, Intel Unite, Intel VPro, Intel Xeon Phi, Iris, Itanium, MAX, Movidius, Myriad, neon, Nios, OpenVINO, the OpenVINO logo, Pentium, Puma, Quark, Quartus, SICOFI, Simics, SMARTi, SoftSilicon, Sound Mark, StarPro, Stratix, the Stratix logo, Stay With It, the Engineering Stay With It logo, StreamSight, Tarari, The Journey Inside, Thunderbolt, the Thunderbolt logo, Transcede, Ultrabook, VTune, Xeon, X-GOLD, XMM, X-PMU and XPOSYS are trademarks of Intel Corporation or its subsidiaries in the U.S. and/or other countries.

Microsoft, Windows, and the Windows logo are trademarks, or registered trademarks of Microsoft Corporation in the United States and/or other countries. Java is a registered trademark of Oracle and/or its affiliates. Bluetooth is a trademark owned by its proprietor and used by Intel Corporation under license. Intel Corporation uses the Palm OS* Ready mark under license from Palm, Inc. OpenCL and the OpenCL logo are trademarks of Apple Inc. used by permission by Khronos. Learn how to use Intel Trademarks and Brands correctly at http://www.intel.com/intel/legal/tmusage2.htm.